

TEST REPORT IEC 62471 Photobiological safety of lamps and lamp systems

Total number of pages:

Testing Laboratory...... SAMSUNG ELETRONICS Co., Ltd.

Applicant's name SAMSUNG ELETRONICS Co., Ltd.

Address 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677,

Korea

Test specification:

Standard.....: IEC 62471:2006 (First Edition)

Test Report Form No. IEC62471A

TRF Originator: VDE Testing and Certification Institute

Master TRF Dated 2009-05

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Test item description: LED PKG

Trade Mark SAMSUNG

Manufacturer Same as Testing Laboratory

Model/Type reference SPHWHAHDNH25YZR3D2

Ratings DC 900 mA / 34,7 V

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Testing procedure and testing location:			
\boxtimes	Testing Laboratory:	SAMSUNG ELETRONICS Co., Ltd. (LED Biz.)	
Test	ing location/ address:	1, Samsung-ro, Giheung-gu, Yongin-si, Gyeonggi-do, 17113, Korea	
	Associated Laboratory:		
Testing location/ address:			
	Tested by (name + signature):		
	Approved by (+ signature):		
	Testing procedure: TMP		
	Tested by (name + signature):		
	Approved by (+ signature):		
Testing location/ address:			
	Testing procedure: WMT		
	Tested by (name + signature):		
	Witnessed by (+ signature):		
	Approved by (+ signature):		
Testing location/ address:			
	Testing procedure: SMT		
	Tested by (name + signature):		
	Approved by (+ signature):		
	Supervised by (+ signature):		
Testing location/ address:			
	Testing procedure: RMT		
	Tested by (name + signature):		
	Approved by (+ signature):		
	Supervised by (+ signature):		
Testing location/ address:			

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Summary of testing:					
Tests performed (name of test and test clause):	Testing location:				
 The sample was applied DC 900mA following by applicant request. The measurement was conducted according to the requirements of TR IEC/EN62778 in conjunction with IEC 62471. All relevant clauses were considered. The sample was measured at 47,5°C(tc). 	SAMSUNG ELETRONICS Co., Ltd 1, Samsung-ro, Giheung-gu, Yongin-si, Gyeonggi-do, 17113, Korea				
Summary of compliance with National Differences:					
The sample(s) tested complies with the requirements of IEC 62471:2006 and EN 62471:2008. See Attachment at the end of this report for compliance with European Group Difference and National Differences.					
Copy of marking plate:					

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Test item particulars				
Tested lamp	□ continuous wave lamps □ pulsed lamps			
Tested lamp system:				
Lamp classification group:	☐ exempt ☐ risk 1 ☐ risk 2 ☐ risk 3			
Lamp cap				
Bulb	LED			
Rated of the lamp:	See Page 1			
Furthermore marking on the lamp:				
Seasoning of lamps according IEC standard:				
Used measurement instrument:				
Temperature by measurement:	24,0 – 25,0 °C			
Information for safety use:	Not required			
Possible test case verdicts:				
 test case does not apply to the test object 	N/A			
 test object does meet the requirement 	P (Pass)			
 test object does not meet the requirement 	F (Fail)			
Testing:				
Date of receipt of test item	2017-03-15			
Date (s) of performance of tests	2017-03-21 ~ 2017-03-22			

General remarks:

The test results presented in this report relate only to the object tested.

This report shall not be reproduced, except in full, without the written approval of the Issuing testing laboratory. "(See Enclosure #)" refers to additional information appended to the report.

"(See appended table)" refers to a table appended to the report.

Throughout this report a comma (point) is used as the decimal separator.

List of test equipment must be kept on file and available for review.

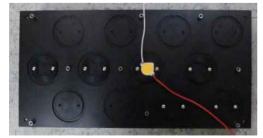
General product information:

Tested products are LED PKG as a light source, model information can be found in the table on next page. The following PKG is tested as representative model.

- PKG: LC033D Gen2

- CCT : 5000K - CRI : 80 - Flux rank : D2

Tested current : DC 900 mAA photo of test sample.



Throughout this report a \boxtimes comma / \square point is used as the decimal separator.